

Notice of References Cited	Application/Control No. 10/813,116		Applicant(s)/Patent Under Reexamination MIYAZAKI ET AL.	
	Examiner Thi Q. Le		Art Unit 2613	Page 1 of 1

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NON-PATENT DOCUMENTS

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	U	IBM Technical Disclosure Bulletin. Electronic Readout Tunnel Diode Memory. June 1, 1965
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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